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PATENT & TRADEMARK OFFICE

[illegible]

FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE PUBLICATION	COUNTRY	INT. CLASS	INT. SUB- CLASS	TRANSLATION	
							YES	NO
PLP	AD	WO 00/51680	08.09.2000	PCT	A61N	1/37		
ICPD	AE	0 617 980 A2	05.10.1994	EPO	A61N	1/368		

[illegible]

EXAMINER	<i>Kristi D. Reed</i>	DATE CONSIDERED	<i>6/14/04</i>
EXAMINER:	Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE (Rev. 2-32) INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO.: P-4825.00	SERIAL NO: RECEIVED 09/998,553 APR - 8 2002 TECHNOLOGY CENTER R3700
	APPLICANT: Wang et al.	
	FILING DATE: November 28, 2001	GROUP:



U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE ISSUED	INVENTOR NAME	U.S. CLASS	U.S. SUB- CLASS	FILING DATE IF APPROPRIATE
<i>KCD</i>	AA	4587976	05/13/86	Schmid et al.	128	699	
	AB	4726380	02/23/88	Vollmann et al.	128	419	
	AG	4947858	08/14/90	Smith	128	696	
	AD	5048521	09/17/91	Pless et al.	128	419	
	AE	5058599	10/22/91	Andersen et al.	128	705	
	AF	5086772	02/11/92	Larnard et al.	128	419	
	AG	5101390	04/28/92	Olive	128	705	
	AH	5111396	05/05/92	Mills et al.	364	413.06	
	AI	5161527	11/10/92	Nappholz et al.	128	419	
	AJ	5193535	03/16/93	Bardy et al.	128	419	
	AK	5205583	04/27/93	Henseler et al.	280	743	
	AL	5217021	06/08/93	Steinhaus et al.	128	702	
	AM	5226425	07/13/93	Righter	128	710	
	AN	5289824	03/01/94	Mills et al.	128	696	
	AO	5311874	05/17/94	Baumann et al.	128	705	
	AP	5312441	05/17/94	Mader et al.	607	5	
<i>✓</i>	AQ	5312446	05/17/94	Holschbach et al.	607	9	
<i>KCD</i>	AR	5313953	05/24/94	Yomtov et al.	128	696	

EXAMINER	<i>Crista D. Doe</i>	DATE CONSIDERED
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KEP	AS	5333616	08/02/94	Mills et al.	128	696	
	AT	5339824	08/23/94	Engira	128	712	
	AU	5342402	08/30/94	Olson et al.	607	5	
	AV	5365935	11/22/94	Righter et al.	128	710	
	AW	5411031	05/02/95	Yomtov	128	706	
	AX	5417717	05/23/95	Salo et al.	607	18	
	AY	5511553	04/30/96	Segalowitz	128	696	
	AZ	5513645	05/07/96	Jacobson et al.	128	710	
	BA	5518001	05/21/96	Snell	128	697	
	BB	5591215	01/07/97	Greenhut et al.	607	14	
	BC	5779645	07/14/98	Olson et al.	600	518	
	BD	5913550	06/22/99	Watanuki	29	603.1	
	BE	5987352	11/16/99	Klein et al.	600	509	
	BF	6141581	10/31/00	Olson et al.	600	515	
	BG	6230059 B1	05/08/01	Duffin	607	60	
✓	BH	6236882 B1	05/22/01	Lee et al.	600	509	
	BI	6275732 B1	08/14/01	Hsu et al.	607	14	
KEP	BJ	6308095 B1	10/23/01	Hsu et al.	600	518	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE PUBLIC- ATION	COUNTRY	INT. CLASS	INT. SUB- CLASS	TRANSLATION	
							YES	NO
KEP	BK	WO 98/02209	01/22/98	PCT	A61N	1/375		

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TECHNOLOGY CENTER R3700
09/998,553

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(Use several sheets if necessary)

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FILING DATE:
November 28, 2001

GROUP:

OTHER DOCUMENTS (Including Author, Title, Date Pertinent Pages, Etc.)

Ken
Tateno et al., A Method for Detection of Atrial Fibrillation Using RR Intervals, Computers in Cardiology 2000, Volume 27, IEEE, September 24-27, 2000, pp 391 – 394.

Ken
Mueller, William C., Arrhythmia Detection Program for an Ambulatory ECG Monitor, ISA, 1978, pp 81-85

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